In the Claims

Claims 1-6 (Cancelled)

- 1 7. (Original) An electron optical column comprising:
- 2 means for generating an electron beam;
- 3 a focus lens; and
- 4 an electrostatic scanning deflector situated above said focus lens, said scanning deflector
- 5 comprising a first deflector and a second deflector configured to provide telecentric scanning of
- 6 said electron beam on a specimen substrate positioned below said focus lens.
- 1 8. (Currently amended) An electron optical column as in claim [[1]] 7, wherein said first
- 2 deflector and said second deflector generate electric fields of opposite polarities.
- 1 9. (Currently amended) An electron optical column as in claim [[1]] 7, wherein said first
- 2 deflector and said second deflector generate deflection fields of different strengths.
- 1 10. (Currently amended) An electron optical column as in claim [[1]] 7, wherein said
- 2 scanning deflector comprises octupole deflectors.
- 1 11. (Currently amended) An electron optics assembly as in claim [[1]] 7, wherein said
- 2 scanning deflector comprises titanium alloy elements brazed to a ceramic substrate.
- 1 12. (Original) An electron optics assembly for a multi-column electron optical system
- 2 comprising:
- means for generating a multiplicity of electron beams;
- a multiplicity of focus lenses, configured such that there is a corresponding focus lens for
- 5 each column; and
- a multiplicity of scanning deflectors situated above said focus lenses, such that there is a
- 7 corresponding scanning deflector for each column, each said scanning deflector comprising a
- 8 first deflector and a second deflector configured to provide telecentric scanning of said electron
- 9 beams on a specimen substrate positioned below said focus lenses.

60367825v1 3

- 1 13. (Currently amended) An electron optics assembly as in claim [[6]] 12, wherein said
- 2 scanning deflectors are electrostatic deflectors.
- 1 14. (Currently amended) An electron optics assembly as in claim [[7]] 12, wherein said first
- 2 deflectors and said second deflectors generate electric fields of opposite polarities.
- 1 15. (Currently amended) An electron optical column as in claim [[6]] 12, wherein said first
- 2 deflectors and said second deflectors generate deflection fields of different strengths.
- 1 16. (Currently amended) An electron optics assembly as in claim [[6]] 12, wherein said
- 2 scanning deflectors are octupole deflectors.
- 1 17. (Currently amended) An electron optics assembly as in claim [[6]] 12, wherein each of

4

2 said scanning deflectors comprises titanium alloy elements brazed to a ceramic substrate.

In the Drawings

A replacement drawing is attached indicating FIG. 17a and FIG. 17b as indicated on page 8, lines 5-8 of the specification.

Attachment: Replacement Sheet

Annotated Sheet Showing Changes

60367825v1

5